Determination of the Surface Phonon Dispersion Relations for Monolayer, Bilayer, Trilayer, and Thick Kr(111) Films Physisorbed on Ag(111) by Inelastic He Scattering

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Angle- and velocity-resolved inelastic He scattering has been used to study how the surface dynamics of thin rare-gas films evolve on a layer-by-layer basis. Surface-phonon dispersion relations for ordered 1-, 2-, 3-, and 25-layer Kr films physisorbed on Ag(111) are presented along \( \Gamma M \) across the entire Brillouin zone. The monolayer data are dispersionless, indicative of an Einstein oscillator mode. In comparison, the 25-layer film has a well-developed Rayleigh wave, typical of a thick crystal surface. Excitation linewidths for monolayer Kr, which vary across the zone, are also briefly discussed.

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The physical and chemical properties of atomically thin adsorbed films are currently being examined in great detail by a variety of experimental and theoretical techniques. In addition to their technological importance, studies on these systems are motivated by a desire to understand the many factors, including the essential role played by the underlying substrate, which contribute to the fascinating phenomena associated with them, e.g., a wide diversity of ordered two-dimensional structures, phase transitions, and novel catalytic activity. To date, much experimental effort has been directed toward elucidating the geometric and electronic properties, i.e., the static properties, of these systems. Only recently have vibrational probes, such as low-energy electron-energy-loss spectroscopy,\(^1\) inelastic neutron scattering,\(^2\) and inelastic He scattering,\(^3\) allowed researchers to directly examine the dynamical properties of atomically thin films. Of these techniques, inelastic He scattering is the best suited for examining low-energy (\( \leq 5 \text{ meV} \)) collective excitations since it has excellent energy resolution (\( \leq 250 \text{ \mu eV} \)), high surface specificity, and momentum sufficient for probing excitations across the entire surface Brillouin zone (SBZ).

In this Letter we present inelastic He scattering data which demonstrate how the surface-phonon dispersion relations for Kr(111) films physisorbed on Ag(111) evolve on a layer-by-layer basis, from monolayer through thick film, across the entire SBZ. These model systems lend themselves to accurate theoretical analysis as a great deal of information exists pertaining to rare-gas interaction potentials and rare-gas–metal physisorption potentials, including two-body and higher-order terms.

The dispersion curves were mapped out with use of angle-resolved He time of flight (TOF). The measurements were performed in a UHV scattering apparatus (base pressure \( \sim 2 \times 10^{-10} \text{ Torr} \)) equipped with a rotatable and differentially pumped quadrupole mass spectrometer (crystal-to-ionizer distance, 14.45 cm; angular resolution, 0.67\(^\circ\)). An important feature of the apparatus is that the incident and final polar scattering angles are independently adjustable. Data can therefore be collected across the entire SBZ with use of a fixed incident angle for a given surface; in large part, this eliminates the necessity of correcting the inelastic transition probabilities for intensity variations that occur because of selective adsorption resonances in the incident channel. The mechanically modulated 18-meV He beam (\( \Delta v/v \sim 1\% \); shutter function, \( \sim 3 \text{ \mu sec FWHM} \)) was produced in a liquid-nitrogen-cooled nozzle-beam source. The Ag single crystal was cut and polished to within 0.5\(^\circ\) of the (111) plane, as confirmed by Laue x-ray back reflection. Surface cleanliness was checked by Auger spectroscopy. When needed, the crystal was cleaned by Ar\(^+\) bombardment, and subsequently annealed at 750 K. Surface coherence was checked by monitoring of the specular scattering line shape of a 64-meV He beam, and analyzed with use of a simple perturbation theory,\(^4\) which indicated a coherence length of circa 100 Å. The azimuthal orientation was determined by use of H\(_2\) diffraction.

Our thin-film growth procedures were guided by extensive information that was already available about the structure and thermodynamics of rare-gas overlayers on Ag(111).\(^5\) Ar, Kr, and Xe form azimuthally aligned but translationally incommensurate lattices on this surface. Monolayers were grown by controlling the pressure of a differentially pumped dosing beam and the surface temperature. Overlayers were grown by subsequent computer-controlled deposition on well-annealed monolayers. The quality and structure of the Kr surfaces were checked by use of He diffraction, as shown in Fig. 1 for four different overlayers. Specular peak widths and intensities indicate that the coherence lengths of these surfaces are only slightly less than the Ag substrate; i.e., we are not growing roughened films. The very low diffuse scattering seen in Fig. 1 also confirms the high quality of the Kr overlayers. The lattice constant for a Kr monolayer, 4.02 Å, is just slightly larger than that for the 2-, 3-, and
25-layer films, 4.00 Å. When the experiments with an overlayer were completed, the coverage was confirmed by use of temperature-programmed thermal desorption (TPD); a Kr-trilayer TPD spectrum is shown in the inset of Fig. 3. Since the monolayer desorption peak occurs at a higher temperature than the multilayer peaks, the ratio of the total integrated area to that of the monolayer gives a quantitative measure of the coverage. Only data collected on films typically falling within 5% of a particular overlayer thickness were used in our analysis for 1-, 2-, and 3-layer structures.

TOF spectra were taken with use of a multichannel scaler (1 μsec/channel dwell time), and required approximately 1 h of signal averaging. The first step in the analysis was to fit the TOF data by a nonlinear least-squares routine. Flight times, referenced to the elastic specular TOF, were then used to determine the phonon energies. The parallel momentum exchange of a given peak could then be calculated by use of the kinematic constraints imposed by the incident and final scattering angles, the phonon energy, and the conservation of crystal momentum. A more detailed description of the experimental apparatus and procedures will be given elsewhere.6

Figure 2 shows typical TOF spectra for the four different Kr overlayers. The well-defined peaks indicate that single-phonon exchanges are the dominant inelastic scattering channel. Each TOF spectrum also includes an elastic feature, which we attribute to incoherent scattering from crystal defects. The computer simulations in Fig. 2 are forward convolutions which have been scaled to show excitation line shapes, but not probabilities, and which (i) use as input the experimental dispersion curves, (ii) include the instrument transfer function, and (iii) assume single-phonon exchanges with delta-function energy widths. When the phonon excitation line shapes are allowed to have finite energy widths, the simulations in most cases fit the experimental spectra, yielding information on phonon relaxation.6 Most of the spectra were intentionally taken at the same incident angle (θi = 45°). An observation made on Xe monolayers indicates why a constant incident angle should be used for quantitative examination of inelastic transition probabilities: It was found that the intensities of the inelastic peaks did not scale linearly with the specular beam at two slightly different incident angles because of the presence of a selective adsorption resonance in the incident channel. Such resonances are common and pronounced features on all of the rare-gas systems that we have examined.7 (Our scattering geometry does not eliminate intensity variations that are due to resonances in the exit channel.)

Figure 3 is a reduced zone plot of the principal modes observed on the 1-, 2-, 3-, and 25-layer Kr films. Only the energy loss and gain features adjacent to the elastic TOF in Fig. 2 are plotted. The layer-by-layer evolution of the surface dynamics of these structures is clearly revealed, with striking differences apparent between the monolayer and the 25-layer films.

![FIG. 1. He diffraction spectra for Kr overlayers physisorbed on Ag(111), taken along the (112) direction, with θi = 45°, Ei = 18 meV, and T = 25 K. The four spectra were collected with use of the same conditions, so that the intensities are directly comparable. Arrows indicate the angles at which the TOF spectra of Fig. 2 were taken.](image)

![FIG. 2. Typical TOF spectra for Kr overlayers physisorbed on Ag(111), taken with the same parameters as in Fig. 1. Dots are experimental data, solid lines are least-squares fits, and dot-dashed lines are simulations (see text). Arrows indicate the position of the elastic time of flight.](image)
FIG. 3. Phonon dispersion curves of the Kr overlayers from $\overline{\Gamma}$ to $\overline{M}$. Open symbols are for energy loss of the beam, and filled symbols are for energy gain. Representative error bars are shown for energy and momentum loss features (with respect to the incident beam) which occurred in the first zone, i.e., for normal processes. Solid lines are polynomial fits to the data. The inset is a typical TPD spectrum for a trilayer. Such spectra were essential as their integrated areas were used to confirm the Kr coverage of each film.

The monolayer $\text{SP}_{L}$ mode, the only mode that we observe, is dispersionless within our experimental error. This indicates that the physisorbed Kr atoms are behaving as independent Einstein oscillators, vibrating in an uncorrelated manner in the well of the holding potential, $V(z)$. We note that this behavior has also been directly observed, $^{3,8}$ and indirectly inferred, $^{10}$ for rare gases physisorbed on graphite and other metallic surfaces. The monolayer $\text{SP}_{L}$ frequency allowed us to determine the second derivative of $V(z)$ at the equilibrium position, and hence the force constant, $k_{\text{Kr-Ag}} = 171$ meVÅ$^{-2}$. Using this parameter in conjunction with the previously determined well depth ($D = 108$ meV),$^{11}$ and $C_{33}$ constant and reference plane ($C_{3} = 2263$ meVÅ$^{-1}$, $z_0 = 0.2521$ Å),$^{12}$ an exponential$^{3}$ parametrization of the holding potential,$^{6}$

$$V(z) = A \exp\left[-\beta(z-z_0)^2\right] - C_3/(z-z_0)^3,$$

with $A = 21.556$ meV and $\beta = 2.407$ Å$^{-1}$ (this potential is not valid for small $z$ as no saturation term was included to account for the singularity at $z_0$). This analysis demonstrates that information on physisorption potentials for heavy adsorbates can be obtained by use of inelastic He scattering, complementing the selective adsorption techniques that are applicable for light adparticles.$^{13}$ Fitting the bottom of the well with

a Morse potential shows $V(z)$ to be nearly harmonic up to level $n = 5$. Figure 4 is a plot of all the inelastic peaks for the monolayer. The average energies are, from bottom to top, 2.93, 5.82, and 8.78 meV—corresponding to 1, 2, and 3 times the fundamental within the precision of our measurements. Since the potential is harmonic near its minimum, and the oscillators are at or near the ground state for the surface temperature of these experiments (25 ± 1 K), we cannot yet unambiguously determine the relative contribution from multiphonon and overtone excitations. Detailed comparisons between the experimental transition probabilities (including temperature-dependent data) and those from scattering calculations, assuming either overtone or multiphonon excitations, should help clarify this situation.

As further overlayers are added there is increasing dispersion (Fig. 3), until at 25 layers a well-developed Rayleigh mode is seen. The energy at the $M$ point (short-wavelength limit) is very nearly the bulk value after adsorption of only two layers. Not surprisingly, the convergence to bulklike behavior is much slower at $\overline{\Gamma}$, where displacements can extend well below the surface.$^{1}$ We were unable to extend the 25-layer measurements to $Q/Q_{\text{max}} < 0.25$ because the weak inelastic TOF peak merged with the tail of the strong elastic signal. Also note that not all of the points plotted in Figs. 3 and 4 are for normal processes, $G = (00)$. Inelastic transitions involving umklapp phonons are in fact quite strong as a result of the high corrugation of the He-Kr(111) potential. All four possible combinations of $\Delta Q$ and $\Delta E$ are observed.

The dispersion curves were primarily mapped out by tracking the most intense energy-loss feature across
the first SBZ for $Q < 0$ (parallel momentum loss with respect to the scattered He). The experimental intensity for this peak was $\sim 10^{-3}$ of the specular beam and $\sim 10^{-4}$ of the incident beam, with a variation of no more than a factor of 5 across the SBZ. This small change in transition probability as a function of $Q$ differs from the large exponential falloff found on metals,\textsuperscript{14} and is partly due to the larger "cut-off factor," $Q_c$,\textsuperscript{13} for this system.\textsuperscript{6,16}

Theoretical dispersion curves for these overlayers have recently been derived.\textsuperscript{17-19} These lattice-dynamics results fit the experimental data quite well when realistic rare-gas potentials and physisorption potentials are used in the calculation. The agreement between theory and experiment gives further evidence that the examined rare-gas films order in a layer-by-layer fashion on Ag(111), i.e., exhibit type-1 growth.\textsuperscript{20}

We are now examining deconvoluted inelastic transition probabilities and line shapes. In our preliminary analysis one interesting trend has already been observed which is related to phonon lifetimes: At small $Q$, when the adsorbate’s Einstein mode overlaps the surface vibrational modes of the substrate, the linewidths are on the order of 1 meV FWHM; whereas at large $Q$, where there is no overlap and the decay pathway is anharmonic, linewidths are relatively narrow, $\leq 0.25$ meV. These observations, and the others reported above, convincingly demonstrate that inelastic He scattering can be used to study the surface dynamics of overlayers, complementing elastic diffraction and selective adsorption measurements which yield information on static properties.\textsuperscript{7,13}

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